

# **Enhancement Mode P-Channel Power MOSFET**

DFN2X2/PMOS/-16V/ $\pm$ 12V/-0.65V/-12A/19m $\Omega$ 

Rev<sub>0.6</sub>





# -16V, 19mΩ, -12A, P-Channel MOSFET

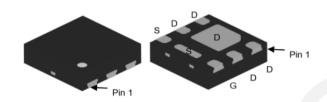
#### 1.Features

- ◆ High Power and current handing capability
- ◆ Lead free product is acquired
- ◆ Surface Mount Package

V <sub>DS</sub> Typ.	R <sub>DS(on)</sub> Typ.	I <sub>D</sub> Max.
-16V	19mΩ @ -4.5V	404
	25mΩ @ -2.5V	-12A

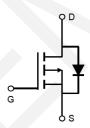
#### 2.Applications

- Battery Protection
- Battery Powered Systems
- Power Management in Notebook Computer
- Portable Equipment



Pin Description

DFN2X2-6L



Schematic Diagram

### 3. Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WX012CP02N2	01 <u>2</u> P02	DFN2X2	3,000	180,000

#### 4.Absolute Max Ratings at Ta=25°C (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	V <sub>DSS</sub>	-16	V
Gate to Source Voltage	V <sub>GSS</sub>	±12	V
Drain Current-Continuous	ID	-12	Α
Drain Current (Pulse)	I <sub>DM</sub>	-48	Α
Maximum Power Dissipation	P <sub>D</sub>	11	W
Operating Junction and Storage Temperature Range	Tj, Tstg	-55 to +150	°C

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



#### 5. Thermal Resistance Ratings (Note 2)

Parameter	Symbol	Value	Unit
Thermal Resistance,Junction to Case	Rejc	11	°C/W

Note 2: When mounted on 1 inch square copper board t ≤ 10sec The value in any given application depends on the user's specific board design.

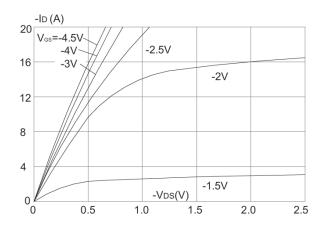
#### 6.Electrical Characteristics at Ta=25°C (Note 3)

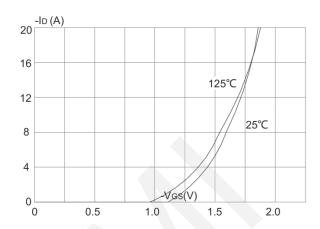
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Units
Drain to Source Breakdown Voltage	V <sub>(BR)DSS</sub>	I <sub>D</sub> = -250μA, V <sub>GS</sub> = 0V	-16	-	-	V
Zero-Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = -16V, V <sub>GS</sub> = 0V	-		-1	μΑ
Gate-Body Leakage Current	Igss	$V_{GS} = \pm 12V, V_{DS} = 0V$	ı	-	±100	nA
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>DS</sub> =-250µA	-0.4	-0.65	-1.0	V
Drain to Source On-State	Б	I <sub>D</sub> =-5A, V <sub>GS</sub> =-4.5V	-	19	25	mΩ
Resistance	R <sub>DS(on)</sub>	I <sub>D</sub> =-3A, V <sub>GS</sub> = -2.5V	-	25	34	mΩ
Input Capacitance	C <sub>iss</sub>	V <sub>GS</sub> =0V,	-	954	-	pF
Output Capacitance	Coss	V <sub>DS</sub> =-10V, Frequency=1.0MHz	-	112	-	pF
Reverse Transfer Capacitance	Crss		-	98	-	pF
Turn-ON Delay Time	t <sub>d(on)</sub>		ı	11	1	ns
Turn-ON Rise Time	tr	$V_{DD}$ =-8V, $I_{D}$ =-5A, $R_{G}$ = 3 $\Omega$ , $V_{GS}$ = -4.5V	-	19	-	ns
Turn-OFF Delay Time	t <sub>d(off)</sub>		-	37	-	ns
Turn-ON Fall Time	t <sub>f</sub>		-	16.8	-	ns
Total Gate Charge	Qg	V <sub>DS</sub> = -8V, V <sub>GS</sub> = -4.5V,	-	11	-	nC
Gate-Source Charge	Qgs		-	0.85	-	nC
Gate-Drain Charge	Q <sub>gd</sub>	I <sub>D</sub> = -5A	-	1.9	-	nC
Diode Forward Voltage	V <sub>SD</sub>	$I_{SD} = -4A$ , $V_{GS} = 0$	-0.5	-	-1.2	V

Note 3: Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

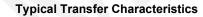


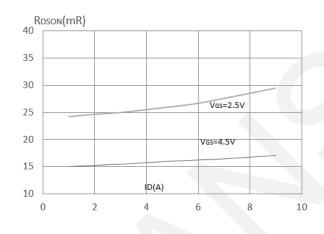
## 7. Typical electrical and thermal characteristics

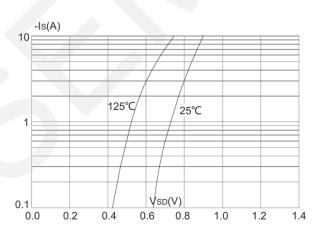




**Typical Output Characteristics** 

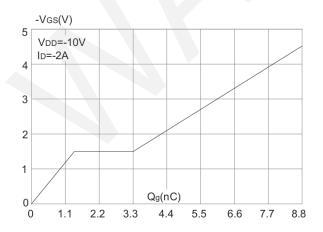


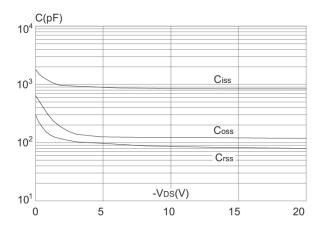




**On-resistance vs. Drain Current** 

**Body Diode Characteristics** 

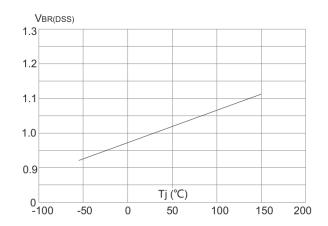


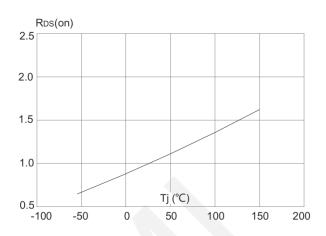


**Gate Charge Characteristics** 

**Capacitance Characteristics** 

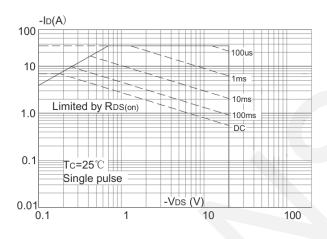


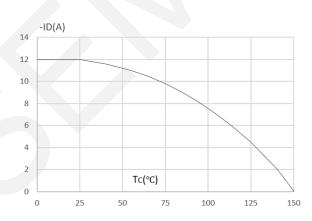




Normalized Breakdown voltage vs. Junction Temperature

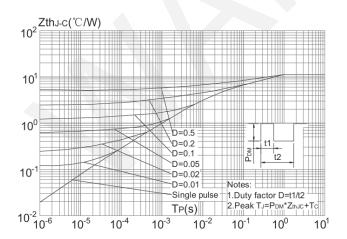






Normalized Breakdown voltage vs. Junction Temperature

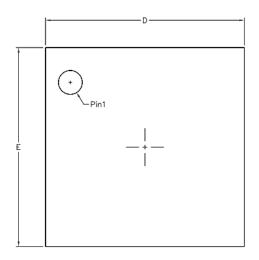
**Current De-rating** 

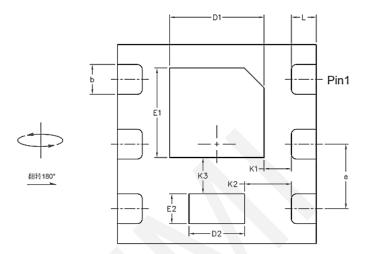


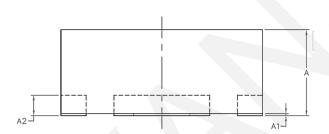
Normalized Maximum Transient Thermal Impedance



## 8.Package Dimensions







SYMBOL	MILLIMETER			
	MIN	NOM	MAXO.	
A	80	0.85	0. 900.	
A1	00	0.02	0.05	
A2	(			
b	0. 27	0.30	0. 33	
D	1.95	2.00	2.05	
Е	1.95	2.00	2.05	
D1	0. 92	0. 95	0.98	
E1	0.87	0.90	0. 93	
D2	0. 53	0. 56	0. 59	
E2	0. 27	0.30	0.33	
е	0. 60	0.65	0. 70 0. 31	
K1	0. 25	0. 28		
K2	0.44	0.47	0.50	
К3	0.34	0. 37	0.40	
L	0. 22	0. 25	0. 28	



#### 9.Important Notice

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